Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

**11 February 2021** 

**Product data sheet** 

## 1. General description

Dual, Logic level N-channel MOSFET in an LFPAK56D package, using Trench 9 TrenchMOS technology. This product has been designed and qualified to AEC-Q101 for use in high performance automotive applications

## 2. Features and benefits

- Fully automotive qualified to AEC-Q101 at 175 °C
- Trench 9 superjunction technology:
  - · Low power losses, high power density
- LFPAK copper clip package technology:
  - · High robustness and reliability
  - Gull wing leads for high manufacturability and AOI
- Repetitive avalanche rated

## 3. Applications

- 12 V, 24 V and 48 V automotive systems
- · Motors, lamps and solenoid control
- Transmission control
- DC-to-DC conversion

## 4. Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		-	-	40	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	[1]	-	-	42	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	-	46	W
Static characte	eristics FET1 and FET2				'		
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ Fig. 11		9.8	14.1	16.9	mΩ
Dynamic chara	acteristics FET1 and FE	T2			'	'	
$Q_{GD}$	gate-drain charge	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 5 V; T <sub>j</sub> = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	1.8	4.2	nC
Source-drain o	liode FET1 and FET2						
Q <sub>r</sub>	recovered charge	$I_S$ = 10 A; $dI_S/dt$ = -100 A/ $\mu$ s; $V_{GS}$ = 0 V; $V_{DS}$ = 20 V; $T_j$ = 25 °C	[2]	-	16.2	-	nC

<sup>[1] 42</sup>A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.



<sup>[2]</sup> Includes capacitive recovery

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# 5. Pinning information

**Table 2. Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1	8 7 6 5	D1 D1 D2 D2
2	G1	gate1	<u> </u>	
3	S2	source2		
4	G2	gate2		
5	D2	drain2		
6	D2	drain2		S1 G1 S2 G2
7	D1	drain1		mbk725
8	D1	drain1	LFPAK56D; Dual LFPAK (SOT1205)	

# 6. Ordering information

**Table 3. Ordering information** 

Type number	ype number Package					
	Name	Description	Version			
BUK9K13-40H	LFPAK56D; Dual LFPAK	plastic, single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

# 7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9K13-40H	91340HK

# 8. Limiting values

#### **Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit	
$V_{DS}$	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 175 °C		-	40	V	
$V_{GS}$	gate-source voltage	DC; T <sub>j</sub> = 25 °C		-20	20	V	
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	46	W	
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	[1]	-	42	А	
		V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; <u>Fig. 2</u>		-	30	А	
I <sub>DM</sub>	peak drain current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 °C$ ; Fig. 3		-	169	А	
T <sub>stg</sub>	storage temperature			-55	175	°C	
Tj	junction temperature			-55	175	°C	
Source-drain	Source-drain diode FET1 and FET2						
Is	source current	T <sub>mb</sub> = 25 °C		-	42	А	
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 °C$		-	169	А	

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Symbol	Parameter	Conditions		Min	Max	Unit
Avalanche Ruggedness FET1 and FET2						
E <sub>DS(AL)S</sub>	non-repetitive drain- source avalanche energy	$I_D$ = 39.9 A; $V_{sup} \le 40$ V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; Fig. 4	[2] [3]	-	10.6	mJ
I <sub>AS</sub>	non-repetitive avalanche current	$V_{sup}$ = 40 V; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $R_{GS}$ = 50 $\Omega$ ; $Fig. 4$	[4]	-	39.9	Α

- [1] 42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [3] Refer to application note AN10273 for further information.
- [4] Protected by 100% test

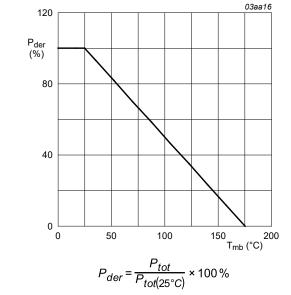
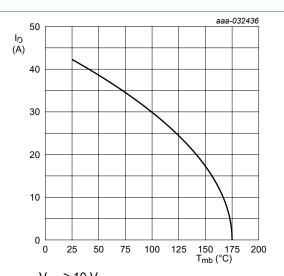


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$  42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2

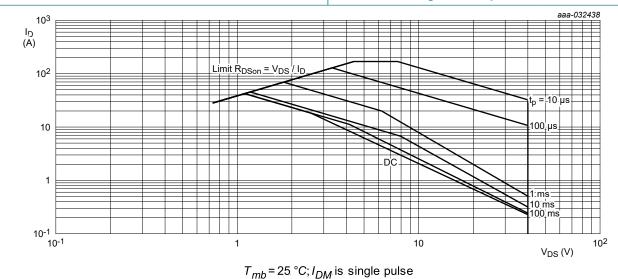
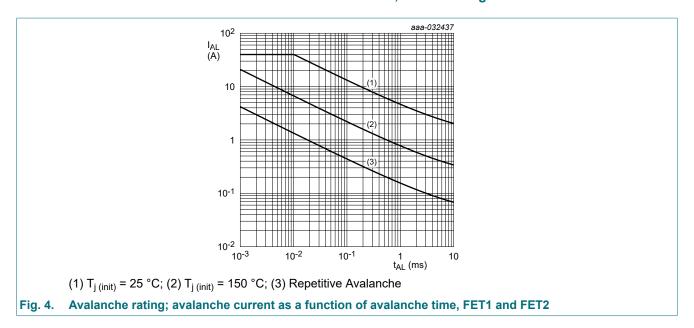


Fig. 3. Safe operating area; continuous and peak drain current as a function of drain-source voltage, FET1 and FET2

## Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D



## 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	3	3.23	K/W

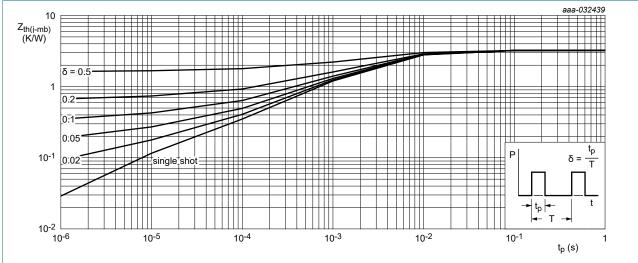


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FFT2

## Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

## 10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics FET1 and FET2					
V <sub>(BR)DSS</sub>	drain-source	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	40	43	-	V
•	breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>i</sub> = -40 °C	-	40.5	-	V
tatic characteristics FET1 and FET2   (BR)DSS drain-source breakdown voltage $I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ I_D = 10 \ m\text{A}; \ V_{DS} = V_{GS}; \ T_J = 100 \ M; \ V_{DS} = 100 \ M; \ V_{DS} = V_{GS}; \ T_J = 100 \ M; \ V_{DS} = 100 \ V; \ V_{DS} = 0 \ V; \ V_{DS} = 100 \ V; \ V_{DS} = 0 \ V; \ V_{DS} = 100 \ V; \ V_{DS} = 0 \ V; \ V_{DS} = 100 \ V; \ V_{DS} = 0 \ V; \ V_{DS} = 100 \ V; \ I_D = 100 \ A; \ T_{GS} = 100 \ V; \ I_D = 100 \ A; \ T_{GS} = 100 \ V; \ I_D = 100 \ A; \ T_{GS} = 100 \ V; \ I_D = 100 \ A; \ T_{GS} = 100 \ V; \ T_J = 25 \ C; \ T_{GS} = 100 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 13; \ T_{GS} = 100 \ V; \ T_J = 25 \ C; \ T_{GS} = 100 \ V; \ T_J = 25 \ C; \ T_{GS} = 100 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 25 \ C; \ T_{GS} = 320 \ V; \ T_J = 250 \ C; \ T_{GS} = 320 \ V; \ T_J = 250 \ C; \ T_{GS} = 320 \ V; \ T_J = 250 \ C; \ T_{GS} = 320 \ V; \ T_J = 2500 \ C; \ T_J = 2500 \ C; \ T_J = 2500000000000000000000000000000000000$	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>i</sub> = -55 °C	36	40	-	V	
V <sub>GS(th)</sub>	1 -	I <sub>D</sub> = 1 mA; V <sub>DS</sub> =V <sub>GS</sub> ; T <sub>j</sub> = 25 °C; <u>Fig. 9</u> ; <u>Fig. 10</u>	1.5	1.85	2.2	V
		$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 175 °C; Fig. 10	0.7	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; Fig. 10$	-	-	2.6	V
DSS	drain leakage current	V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	0.01	5	μA
		V <sub>DS</sub> = 16 V; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 125 °C	-	0.14	10	μΑ
		V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 175 °C	-	26	500	μΑ
l <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = -10 V; V <sub>DS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	2	100	nA
		V <sub>GS</sub> = 16 V; V <sub>DS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	2	100	nA
R <sub>DSon</sub>		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C; Fig. 11	7.9	11.4	13.6	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 105 °C; Fig. 12	10.9	16	20.4	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 125 °C; Fig. 12	12	17.4	21.9	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 175 °C; Fig. 12	14.5	20.9	26.4	mΩ
			$V_{GS}$ = 4.5 V; $I_{D}$ = 10 A; $T_{j}$ = 25 °C; Fig. 11	9.8	14.1	16.9
		$V_{GS}$ = 4.5 V; $I_{D}$ = 10 A; $T_{j}$ = 105 °C; Fig. 12	13.5	20	25.4	mΩ
		$V_{GS}$ = 4.5 V; $I_{D}$ = 10 A; $T_{j}$ = 125 °C; Fig. 12	14.8	21.6	27.2	mΩ
		V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 175 °C; Fig. 12	18	26.6	32.8	mΩ
$R_G$	gate resistance	f = 1 MHz; T <sub>j</sub> = 25 °C	0.7	1.8	4.2	Ω
Oynamic ch	naracteristics FET1 and FE	T2				
$Q_{G(tot)}$	total gate charge	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 32 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	-	13	19.4	nC
		$I_D = 10 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 5 \text{ V};$	-	6.8	10.2	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	-	2.3	3.8	nC
$Q_{GD}$	gate-drain charge		-	1.8	4.2	nC
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 25 V; V <sub>GS</sub> = 0 V; f = 1 MHz;	-	848	1160	pF
Coss	output capacitance	T <sub>j</sub> = 25 °C; <u>Fig. 15</u>	-	280	420	pF
C <sub>rss</sub>	reverse transfer capacitance		-	39	84	pF
d(on)	turn-on delay time	$V_{DS} = 32 \text{ V}; R_L = 3.2 \Omega; V_{GS} = 5 \text{ V};$	-	6.5	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 ^{\circ}C$	-	9.7	-	ns
d(off)	turn-off delay time		-	10.1	-	ns

### Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t <sub>f</sub>	fall time			-	7.8	-	ns
Source-drain diode FET1 and FET2							
$V_{SD}$	source-drain voltage	$I_S = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}; Fig. 16$		-	0.81	1	V
t <sub>rr</sub>		$I_S = 10 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$		-	21.5	-	ns
Q <sub>r</sub>	recovered charge	$V_{DS} = 20 \text{ V; T}_{j} = 25 \text{ °C}$	[1]	-	16.2	-	nC

#### [1] Includes capacitive recovery

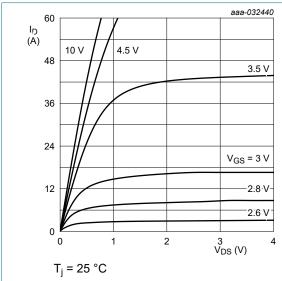


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values, FET1 and FET2

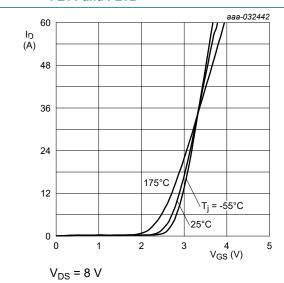


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values, FET1 and FET2

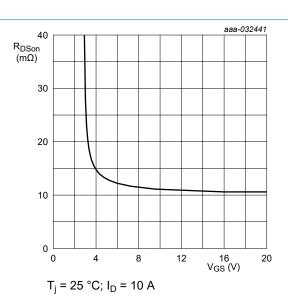


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values. FET1 and FET2

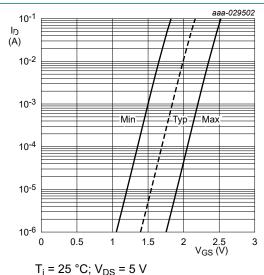


Fig. 9. Sub-threshold drain current as a function of gate-source voltage, FET1 and FET2

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### Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

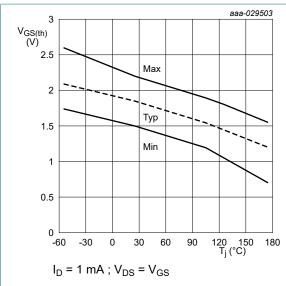


Fig. 10. Gate-source threshold voltage as a function of junction temperature, FET1 and FET2

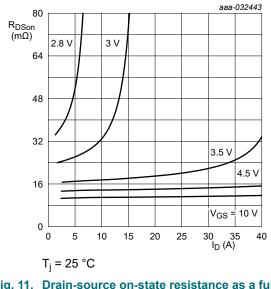


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

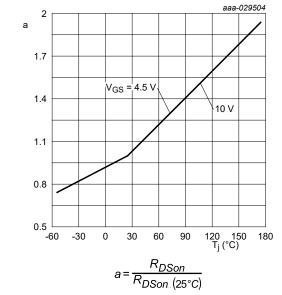


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

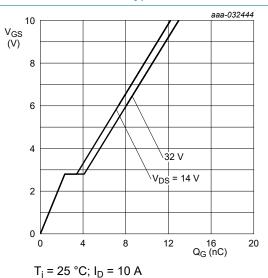


Fig. 13. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

## Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

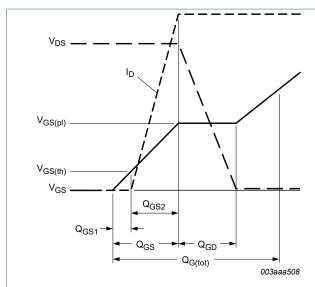


Fig. 14. Gate charge waveform definitions

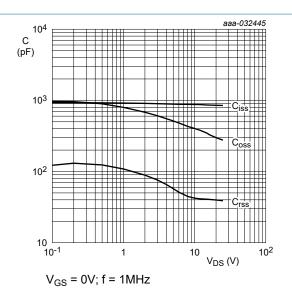


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2

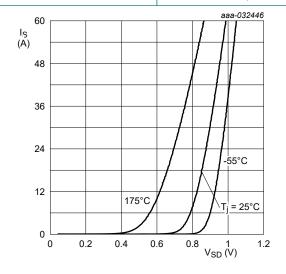


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values FET1 and FET2

 $V_{GS} = 0 V$ 

### Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

# 11. Package outline

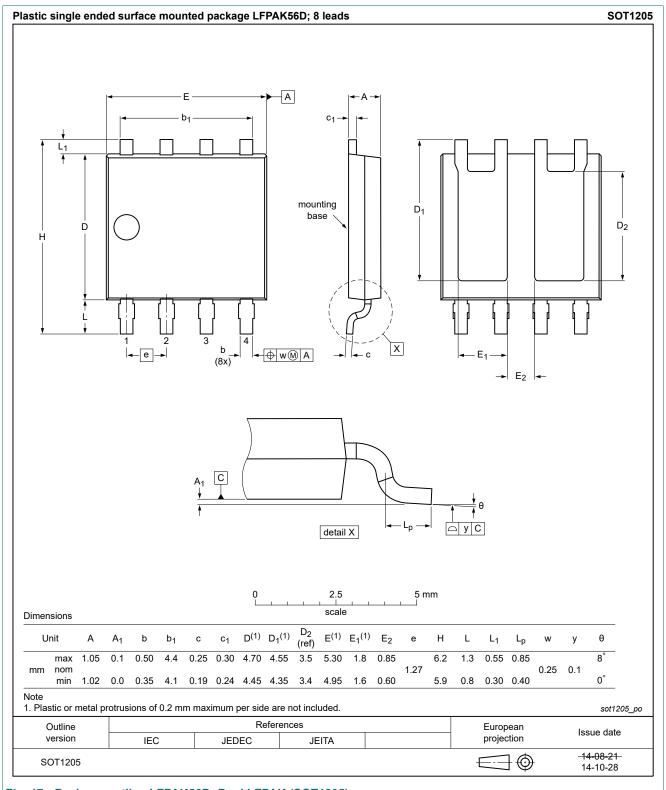
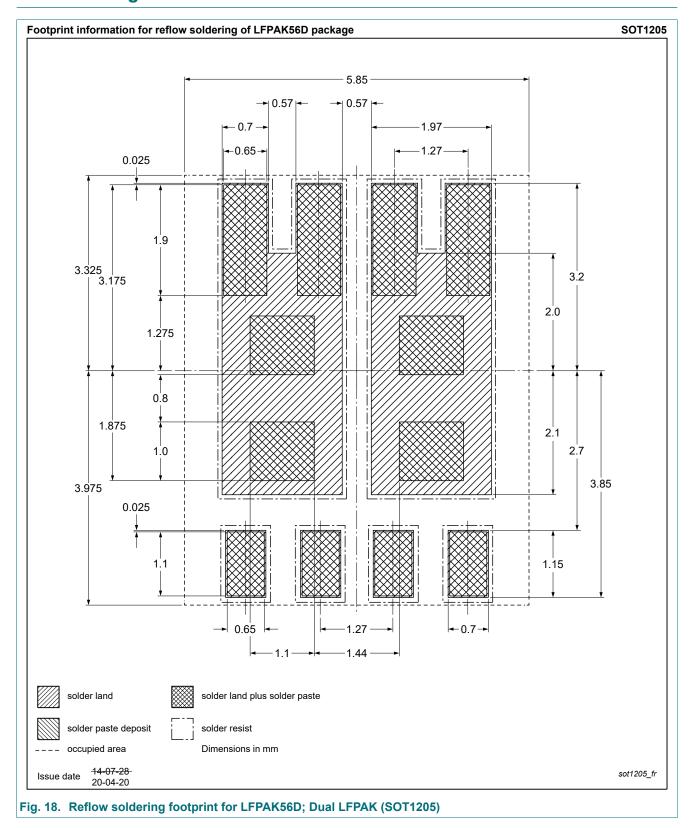


Fig. 17. Package outline LFPAK56D; Dual LFPAK (SOT1205)

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## Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

# 12. Soldering



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### Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

## 13. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
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## Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D

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